# Self-Protected Low Side Driver with Temperature and Current Limit

NCV8401A/B is a three terminal protected Low-Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain-to-Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

#### **Features**

- Short Circuit Protection
- Thermal Shutdown with Automatic Restart
- Over Voltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

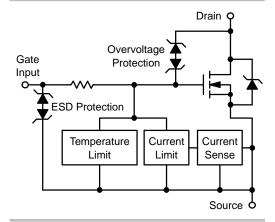


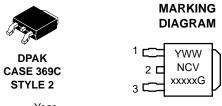
## ON Semiconductor®

#### www.onsemi.com

V <sub>DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX (Limited)
42 V	23 mΩ @ 10 V	33 A*

\*Max current may be limited below this value depending on input conditions.





Y = Year

WW = Work Week 1 = Gate xxxxx = 8401A or 8401B 2 = Drain G = Pb-Free Package 3 = Source

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCV8401ADTRKG	DPAK (Pb-Free)	2500/Tape & Reel
NCV8401BDTRKG	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit		
Drain-to-Source Voltage Internally Clamped			42	V	
Drain-to-Gate Voltage Internally Clamped $(R_{GS} = 1.0 \text{ M}\Omega)$			42	V	
Gate-to-Source Voltage			±14	V	
Drain Current – Continuous			Internally Limited		
Total Power Dissipation  @ $T_A = 25^{\circ}C$ (Note 1)  @ $T_A = 25^{\circ}C$ (Note 2)		P <sub>D</sub>	1.1 2.0	W	
Thermal Resistance,  Junction-to-Case  Junction-to-Ambient (Note 1)  Junction-to-Ambient (Note 2)		$egin{array}{l} R_{ hetaJC} \ R_{ hetaJA} \ R_{ hetaJA} \end{array}$	1.6 110 60	°C/W	
Single Pulse Drain–to–Source Avalanche Energy ( $V_{DD}$ = 25 Vdc, $V_{GS}$ = 5.0 Vdc, $I_L$ = 3.65 Apk, $L$ = 120 mH, $R_G$ = 25 $\Omega$ , $T_{Jstart}$ = 150°C) (Note 3)		E <sub>AS</sub>	800	mJ	
Load Dump Voltage (V <sub>GS</sub> = 0 and 10 V, R <sub>I</sub> = $2.0~\Omega$ , R <sub>L</sub> = $3.0~\Omega$ , t <sub>d</sub> = $400~ms$ )			65	V	
Operating Junction Temperature		TJ	-40 to 150	°C	
Storage Temperature			-55 to 150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Minimum FR4 PCB, steady state.

- 2. Mounted onto a 2" square FR4 board (1" square, 2 oz. Cu 0.06" thick single–sided, t = steady state).
- 3. Not subject to production testing.

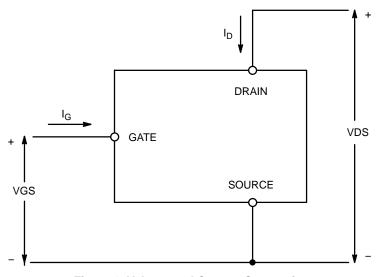


Figure 1. Voltage and Current Convention

# $\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Characte	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Clamped Breakdown Vo (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 250 $\mu$ Adc) (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 250 $\mu$ Adc, T <sub>o</sub>	V <sub>(BR)DSS</sub>	42 42	46 44	50 50	Vdc	
Zero Gate Voltage Drain Current $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J})$	I <sub>DSS</sub>		1.5 6.5	5.0	μAdc	
Gate Input Current ( $V_{GS} = 5.0 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$ )	I <sub>GSSF</sub>		50	100	μAdc	
ON CHARACTERISTICS						
	V <sub>GS(th)</sub>	1.0	1.8 5.0	2.0	Vdc -mV/°C	
Static Drain-to-Source On-Resistance (N $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$ (V $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$	R <sub>DS(on)</sub>		23 43	29 55	mΩ	
Static Drain-to-Source On-Resistance (N $_{GS}$ = 5.0 Vdc, I $_{D}$ = 5.0 Adc, T $_{CS}$ (V $_{GS}$ = 5.0 Vdc, I $_{D}$ = 5.0 Adc, T $_{CS}$	R <sub>DS(on)</sub>		28 50	34 60	mΩ	
Source–Drain Forward On Voltage (I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V)	V <sub>SD</sub>		0.80	1.1	V	
SWITCHING CHARACTERISTICS (Note	4)	•	•	•	•	•
Turn-ON Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )	V <sub>IN</sub> = 0 V to 5 V, V <sub>DD</sub> = 25 V	t <sub>ON</sub>		41	50	μs
Turn-OFF Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )	$I_D = 1.0 \text{ A}, \text{ Ext R}_G = 2.5 \Omega$	t <sub>OFF</sub>		129	150	1
Turn-ON Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )	V <sub>IN</sub> = 0 V to 10 V, V <sub>DD</sub> = 25 V	t <sub>ON</sub>		16	25	
Turn-OFF Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )	$I_D = 1.0 \text{ A, Ext R}_G = 2.5 \Omega$	t <sub>OFF</sub>		164	180	1
Slew-Rate ON (80% V <sub>DS</sub> to 50% V <sub>DS</sub> )	$V_{in}$ = 0 to 10 V, $V_{DD}$ = 12 V, $R_L$ = 4.7 $\Omega$	-dV <sub>DS</sub> /dt <sub>ON</sub>		1.27	2.0	V/μs
Slew–Rate OFF (50% $V_{DS}$ to 80% $V_{DS}$ )	$R_L = 4.7 \Omega$	dV <sub>DS</sub> /dt <sub>OFF</sub>		0.36	0.75	
SELF PROTECTION CHARACTERISTIC	<b>S</b> ( $T_J = 25^{\circ}C$ unless otherwise noted)					
Current Limit	$V_{GS} = 5.0 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = 5.0 \text{ V}, T_J = 150^{\circ}\text{C} \text{ (Note 4)}$	I <sub>LIM</sub>	25 11	30 16	35 21	Adc
	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = 10 \text{ V}, T_J = 150^{\circ}\text{C} \text{ (Note 4)}$		30 18	35 25	40 28	
Temperature Limit (Turn-off)	$V_{GS} = 5.0 \text{ V (Note 4)}$	T <sub>LIM(off)</sub>	150	175	200	°C
Thermal Hysteresis	V <sub>GS</sub> = 5.0 V	$\Delta T_{LIM(on)}$		15		°C
Temperature Limit (Turn-off)	V <sub>GS</sub> = 10 V (Note 4)	$T_{LIM(off)}$	150	165	185	°C
Thermal Hysteresis	V <sub>GS</sub> = 10 V	$\Delta T_{LIM(on)}$		15		°C
GATE INPUT CHARACTERISTICS (Note	<u>'</u>		1		1	1
Device ON Gate Input Current	$V_{GS} = 5 V I_D = 1.0 A$	I <sub>GON</sub>		50	100	μΑ
	$V_{GS} = 10 \text{ V } I_D = 1.0 \text{ A}$			400	700	
Current Limit Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I <sub>GCL</sub>		0.1	0.5	mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.7	1.0	
Thermal Limit Fault Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I <sub>GTL</sub>		0.6	1.0	mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			2.0	4.0	
ESD ELECTRICAL CHARACTERISTICS	$(T_J = 25^{\circ}C \text{ unless otherwise noted}) (N_J = 25^{\circ}C \text{ unless otherwise noted})$	1	1		1	
Electro-Static Discharge Capability Human Body Model (HBM) Machine Model (MM)		ESD	4000 400			V

<sup>4.</sup> Not subject to production testing.
5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

## **TYPICAL PERFORMANCE CURVES**

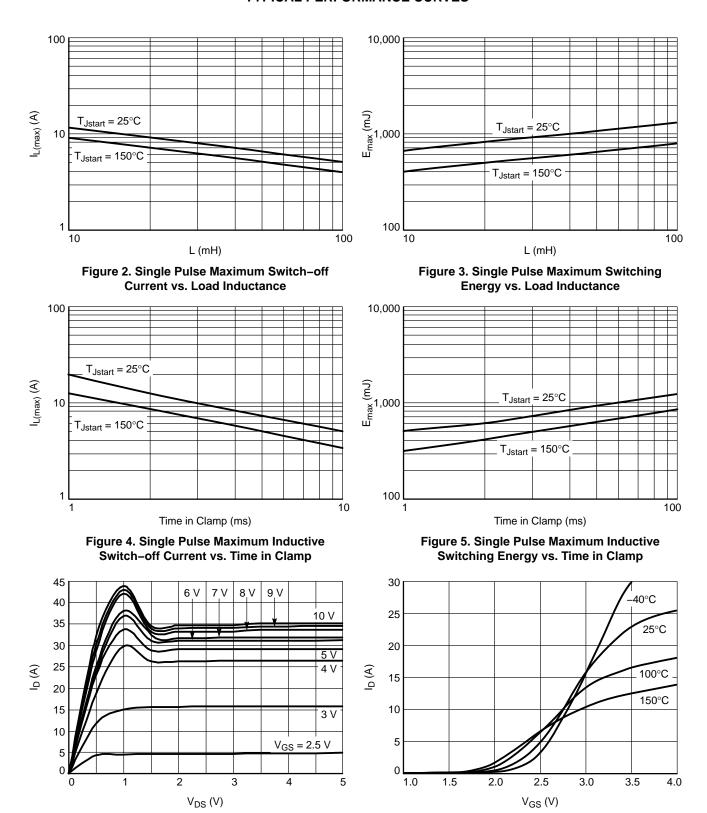


Figure 6. On–state Output Characteristics Figure 7. Transfer Characteristics ( $V_{DS} = 10 \text{ V}$ ) at 25°C

#### **TYPICAL PERFORMANCE CURVES**

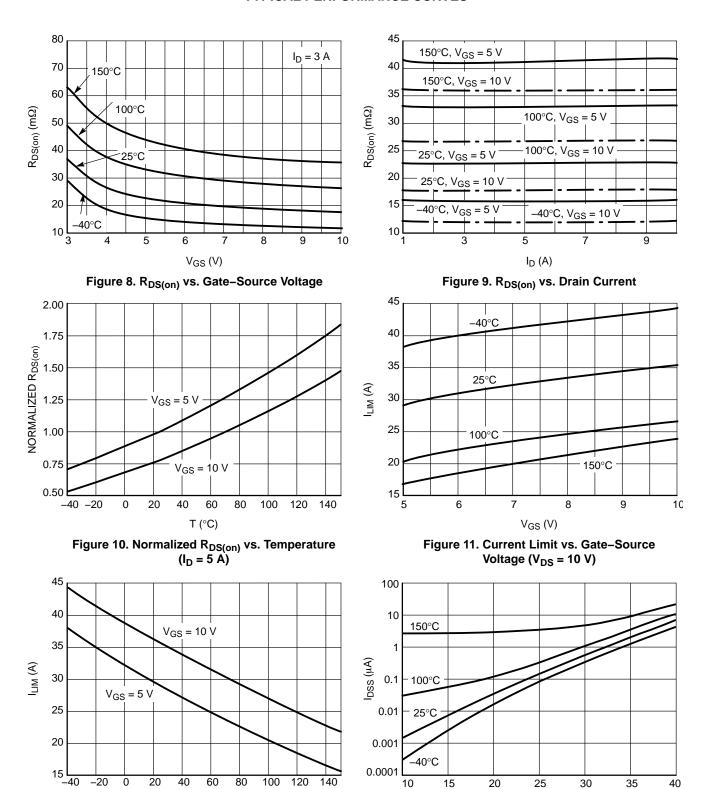


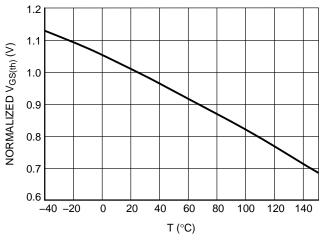
Figure 12. Current Limit vs. Junction Temperature  $(V_{DS} = 10 \text{ V})$ 

T<sub>J</sub> (°C)

Figure 13. Drain-to-Source Leakage Current (V<sub>GS</sub> = 0 V)

 $V_{DS}(V)$ 

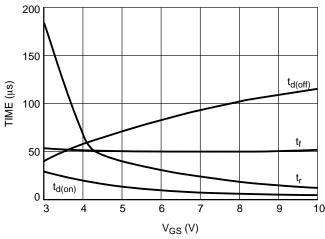
#### **TYPICAL PERFORMANCE CURVES**



1.0 0.9 -40°C 8.0 25°C  $V_{SD}(V)$ 0.7 100°C 0.6 150°C 0.5 0.4 2 5 6 8 9 10 3 4 I<sub>S</sub> (A)

Figure 14. Normalized Threshold Voltage vs. Temperature ( $I_D = 1.2 \text{ mA}, V_{DS} = V_{GS}$ )

Figure 15. Source-Drain Diode Forward Characteristics (V<sub>GS</sub> = 0 V)



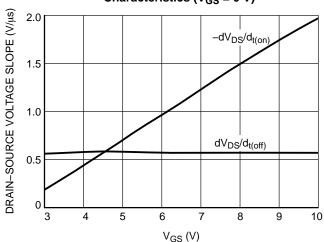
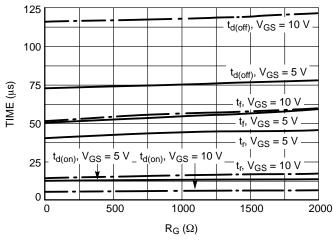


Figure 16. Resistive Load Switching Time vs. Gate–Source Voltage ( $V_{DD}$  = 25 V,  $I_{D}$  = 5 A,  $R_{G}$  = 0  $\Omega$ )

Figure 17. Resistive Load Switching Drain–Source Voltage Slope vs. Gate–Source Voltage ( $V_{DD}$  = 25 V,  $I_{D}$  = 5 A,  $R_{G}$  = 0  $\Omega$ )



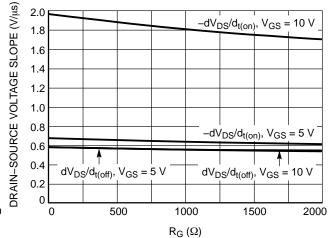


Figure 18. Resistive Load Switching Time vs. Gate Resistance ( $V_{DD} = 25 \text{ V}$ ,  $I_D = 5 \text{ A}$ )

Figure 19. Drain–Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance ( $V_{DD} = 25 \text{ V}, I_D = 5 \text{ A}$ )

#### **TYPICAL PERFORMANCE CURVES**

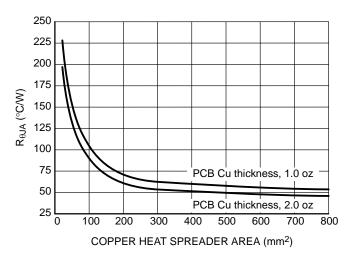


Figure 20.  $R_{\theta JA}$  vs. Copper Area

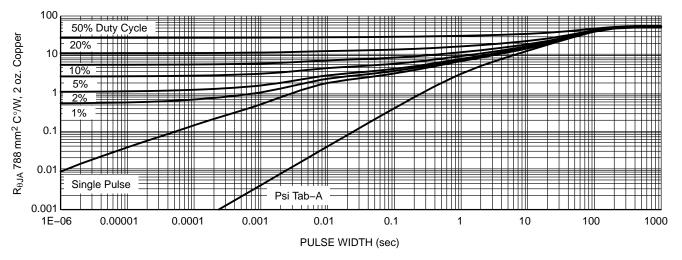


Figure 21. Transient Thermal Resistance

# **TEST CIRCUITS AND WAVEFORMS**

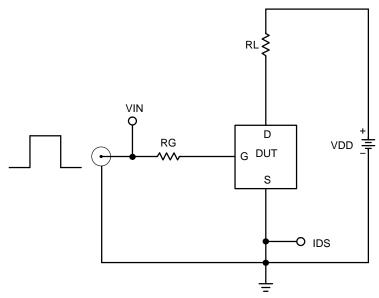


Figure 22. Resistive Load Switching Test Circuit

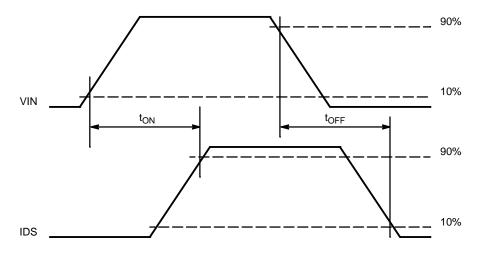


Figure 23. Resistive Load Switching Waveforms

# **TEST CIRCUITS AND WAVEFORMS**

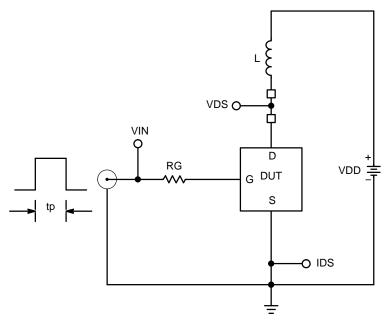


Figure 24. Inductive Load Switching Test Circuit

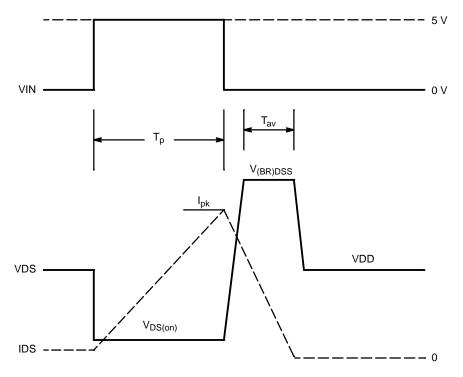
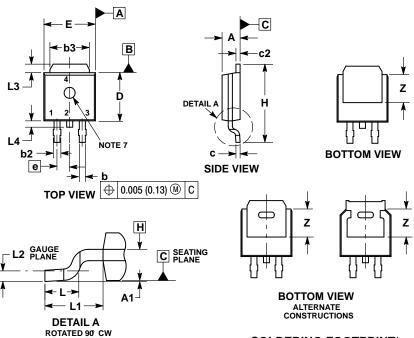


Figure 25. Inductive Load Switching Waveforms

## PACKAGE DIMENSIONS

#### **DPAK** CASE 369C ISSUE F



- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- MENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 7. OPTIONAL MOLD FEATURE.

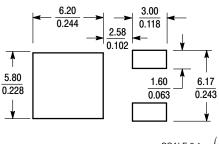
	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2:

- PIN 1. GATE 2. DRAIN

  - 3. SOURCE 4. DRAIN

#### **SOLDERING FOOTPRINT\***



mm SCALE 3:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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